

Non-Stoichiometry Effects on the Extreme Magnetoresistance in Weyl Semimetal WTe_2 *

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Non-stoichiometry effect on the extreme magnetoresistance is systematically investigated for the Weyl semimetal WTe_2 . Magnetoresistance and Hall resistivity are measured for the as-grown samples with a slight difference in Te vacancies and the annealed samples with increased Te vacancies. The fits to a two-band model show that the magnetoresistance is strongly dependent on the residual resistivity ratio (i.e., the degree of non-stoichiometry), which is eventually understood in terms of electron doping that not only breaks the balance between electron-type and hole-type carrier densities, but also reduces the average carrier mobility. Thus the compensation effect and ultrahigh mobility are probably the main driving force of the extreme magnetoresistance in WTe_2 .

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Giant or colossal magnetoresistance (MR) is one of the most important properties in magnetic multilayers and manganites.^[1,2] Such a novel property can be utilized to make multifunctional devices, e.g., magnetic sensors,^[3] magnetic memory,^[4] and hard drives.^[5] However, the materials with a colossal MR are mostly insulators or semiconductors, the MR in conventional metals is usually very small, showing quadratic field dependence in low fields and saturated in high fields.^[6] The extremely large and non-saturated positive MR (XMR) has been recently discovered in a number of metals or semimetals, including Cd_3As_2 ,^[7,8] TaP,^[9,10] WTe_2 ,^[11,12] $PtSn_4$,^[13,14] antimonides,^[15–18] etc. Particularly, some of the XMR materials have been demonstrated or predicted to possess a topological semimetal state. For example, Cd_3As_2 is a Dirac semimetal,^[19] and WTe_2 is a type-II Weyl semimetal.^[20]

Different from the colossal MR effect, in which the carrier scattering from magnetic disorder and spin fluctuation is greatly suppressed under magnetic field,^[2] various mechanisms are proposed to explain the XMR phenomena. In LaBi and LaSb, the XMR is attributed to the electron-hole compensation,^[21] which means a perfect balance between the electron and hole populations. For Cd_3As_2 and the TaAs family, the large MR cannot be simply understood in terms of the compensation effect, and one proposed scenario is that the novel topological protection suppresses the backscattering at zero magnetic field.^[7,9] Spectroscopic evidence shows that the XMR in YSb is special, because YSb lacks both topological protection

and electron-hole compensation.^[22] The large MR of $PtSn_4$ is associated with its ultrahigh mobility.^[13]

Among these systems, WTe_2 is a unique one whose XMR shows no sign of saturation in the magnetic field, even when it is as high as 60 T.^[11] This discovery has triggered extensive research to reveal its origin. Based on electronic structure calculation, the XMR in bulk WTe_2 is ascribed to the compensation mechanism, which is supported by the angle-resolved photoemission spectroscopy (ARPES) results and the quantum transport experiments.^[23–25] Even though, other possible origins are proposed, a distinct reduction in electron density occurs below 50 K indicating a possible electronic structure change, which may be the direct driving force of compensation and XMR.^[26] The circular dichroism observed in another ARPES experiment suggests that the spin-orbit coupling and related spin and orbital angular momentum textures play an important role in the XMR.^[27] Also, the charge compensation is highly dependent on the sample thickness. The balance of electron and hole states is respected only when considering at least three Te-W-Te layers,^[28] which may suggest other mechanisms in thin samples. Recently, a few experiments have attempted to find out the origin by gate-tuning the carrier density of a thin sample *in situ*.^[29–31] The origin of the XMR in WTe_2 is still under debate.

In this work, we try to study the non-stoichiometry effect in WTe_2 by comparing the samples with different Te vacancies, which are introduced during the natural growth or annealing process. MR and Hall resistivity are measured for the as-grown samples with

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a slight difference in Te vacancies. The fits to a two-band model show that the MR is strongly dependent on the residual resistivity ratio (RRR), which is eventually understood in terms of electron doping, which not only breaks the electron-hole balance but also reduces the average carrier mobility. Such a combined mechanism is further confirmed on the annealed samples with increased Te vacancies. Thus the compensation effect and ultrahigh mobility are probably the main driving force of the XMR in WTe_2 .

Single crystals of WTe_2 were grown with Te flux. To obtain samples of different qualities, source powders of tungsten and tellurium were prepared at a series of chemical ratios. The powder mixture was placed in an alumina crucible, with another crucible containing quartz wool mounted on top of it. Both crucibles were sealed in a silica ampoule, heated to 1000°C and held for 10 h, and then cooled down to 600°C at a rate of $2^\circ\text{C}/\text{h}$. The excess Te flux was removed by centrifugation at 600°C . The crystal structure and phase purity were checked by single crystal x-ray diffraction (XRD) on a Rigaku-TTR3 x-ray diffractometer using $\text{Cu } K\alpha$ radiation, and the morphology was characterized on a Hitachi TM3000 scanning electron microscope (SEM). The chemical components of as-grown samples and annealed samples were obtained on an Oxford energy dispersive spectroscope (EDS). All the annealed samples were cut from the same piece of an as-grown sample, and then annealed in a vacuum for different time lengths. The MR and Hall measurements were taken on a home-built multi measurement system on a Janis-9 T magnet.

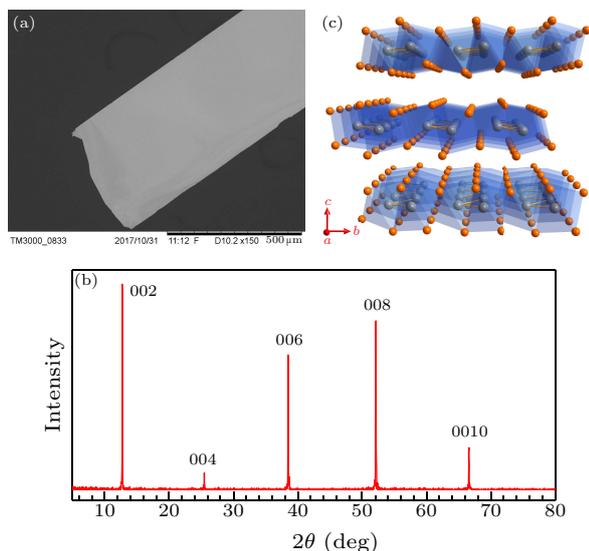


Fig. 1. (a) SEM image of WTe_2 single crystal. (b) Single crystal XRD pattern. (c) Crystal structure of WTe_2 along the a axis that is parallel to the W-W zigzag chains. Silver and orange spheres represent W and Te atoms, respectively.

As seen in the SEM image in Fig. 1(a), the as-grown WTe_2 single crystal exhibits ribbon-like morphology with clean and shining surface. The sin-

gle crystal XRD pattern shows only $(00l)$ peaks (Fig. 1(b)), confirming that the naturally cleaved surface is the a - b plane and the sample is a single phase, i.e., $Pmn2_1$.^[31] Figure 1(c) illustrates the crystal structure, in which silver and orange spheres represent W and Te atoms, respectively. From Fig. 1(c), we find that WTe_2 adopts a typical crystal structure of layered transition metal dichalcogenides (TMDs), namely, a metal layer located between adjacent chalcogenide layers. Such sandwich sheets stack along the c axis, with van der Waals bonding between them. As a result of the strong anisotropy, WTe_2 is typically electronically two-dimensional. Moreover, another structural feature is present in WTe_2 . The zigzag tungsten chains are formed along the a axis, making it structurally quasi-one-dimensional.

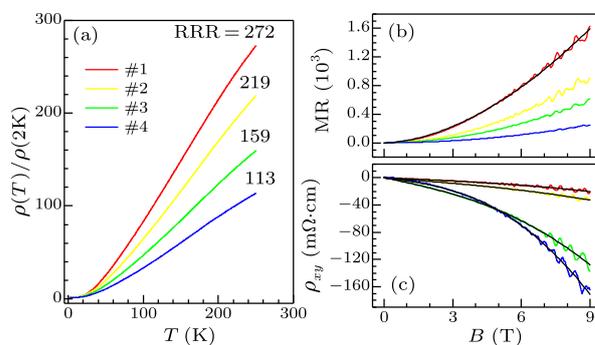


Fig. 2. (a) Temperature dependence of resistivity normalized by $\rho(2\text{K})$ for samples 1, 2, 3, and 4, with the current applied along the a axis. Residual resistivity ratio (RRR), defined as $\rho(250\text{K})/\rho(2\text{K})$, is also presented. (b) Longitudinal MR and (c) Hall resistivity taken at 2 K in a field range of 0–9 T. Non-oscillatory curve in (b) represents the power-law fit; non-oscillatory curves in (c) represent the fits to the two-band model.

Figure 2(a) shows the temperature dependence of resistivity for the as-grown samples of different qualities, denoted by samples 1, 2, 3, and 4, respectively. As described above, these samples are grown from source powders at various ratios, although the EDS characterizations show that they all keep good chemical stoichiometry without any detectable difference. The sample quality can be roughly evaluated by the residual resistivity ratio (RRR), defined as the ratio of resistivity at room temperature and at 0 K, which is strongly depending on the amounts of impurities and defects. In the present work, the RRR takes the value $\frac{\rho(250\text{K})}{\rho(2\text{K})}$. As shown in Fig. 2(a), all the samples exhibit a metallic behavior with a small resistivity. However, the RRR ranges from 113 to 272, reflecting different qualities of samples, i.e., the degree of non-stoichiometry.

The longitudinal MR ($\frac{\Delta\rho}{\rho_0} = \frac{\rho_H - \rho_0}{\rho_0}$) and Hall resistivity are further measured at 2 K under a magnetic field up to 9 T, with the current applied along the a axis and the magnetic field along the c axis. The extremely large MR is reproduced on our samples, e.g., about $1.6 \times 10^5\%$ at 9 T for sample 1. The

XMR and Hall resistivity vary significantly for different samples. Namely, with the increase of RRR, the XMR gets larger and larger while the Hall resistivity (negative) becomes smaller and smaller. Such a positive correlation between RRR and XMR is consistent with the previous report.^[32] If we note that the RRR reflects the sample quality and degree of non-stoichiometry, we can deduce that the larger XMR is corresponding to the better stoichiometry. To check the compensation effect on XMR, a two-band model is used to fit the MR and Hall resistivity data and to extract the density and mobility of carriers. In this model, the longitudinal resistivity ρ_{xx} and Hall resistivity ρ_{xy} read^[26]

$$\rho_{xx} = \frac{(n_e\mu_e + n_h\mu_h) + (n_e\mu_e\mu_h^2 + n_h\mu_h^2\mu_e)B^2}{e[(n_e\mu_e + n_h\mu_h)^2 + (n_h - n_e)^2\mu_e^2\mu_h^2B^2]}, \quad (1)$$

$$\rho_{xy} = \frac{(n_h\mu_h^2 - n_e\mu_e^2)B + \mu_e^2\mu_h^2(n_h - n_e)B^3}{e[(n_e\mu_e + n_h\mu_h)^2 + (n_h - n_e)^2\mu_e^2\mu_h^2B^2]}, \quad (2)$$

where e is the electron charge, n is the carrier density, μ is the mobility, and the subscripts e and h refer to electron-type and hole-type carriers, respectively. According to the model, the condition for ρ_{xx} to increase as B^2 is $n_e = n_h$, which means that electrons and holes are perfectly compensated by each other. Moreover, this model also suggests that ρ_{xy} should be proportional to B , i.e., linearly field dependent, for the perfect compensation. Slight deviation from the perfect compensation will cause a nonlinear field dependence of Hall resistivity in the high field region. A simple power-law fit for sample 1 (which has the best quality) gives $\text{MR} \propto B^{1.77}$ (as shown in Fig. 2(b)), as well as the nonlinear $\rho_{xy}(B)$ curves, suggesting that the samples are not in the perfectly compensated regime. Further fittings using the above equations result in the carrier densities (n_e , n_h) and mobilities (μ_e , μ_h). Non-oscillatory curves in Fig. 2(c) represent the fitted curves, which agree well with the experimental data, showing sufficiently good fits and reliable fitting results.

Figure 3(a) presents the MR and n_e/n_h as a function of RRR for all the as-grown samples, obtained from Fig. 2. It is found that with the increase of RRR and XMR, the ratio n_e/n_h gradually approaches the perfect compensation value, i.e., 1. That is to say, the dependence of XMR on the RRR can indeed be interpreted as the change of n_e/n_h . For a sample of higher quality, the less defects correspond to a larger RRR, and the more balanced n_e/n_h ratio gives rise to a larger XMR. The similar phenomenon has been found in the investigation on the temperature dependence of XMR.^[26]

Since the XMR is strongly dependent on the non-stoichiometry effect, artificial defects may be introduced for further research, considering that the naturally as-grown samples are very close to each other in stoichiometry but a distinct gradient of vacancies can be obtained by the annealing processes. Differ-

ent time lengths of annealing in a vacuum yield a series of non-stoichiometric samples, i.e., 0%, 6.7%, and 9.7%. The percentages represent the degree of Te vacancies, setting the as-grown sample as 0%. As shown in Figs. 4(a)–4(c), with the increase of Te vacancies, the RRR and XMR are greatly reduced. The degradation of sample quality indeed suppresses the XMR. To reveal the underlying information, again we fit the MR and Hall resistivity to the two-band model. The resultant n_e/n_h ratios are plotted as a function of Te vacancies in Fig. 3(b), along with the XMR. We can see that the introduced defects in the annealed samples indeed lead to a less compensated n_e/n_h , which is eventually responsible for the reduced XMR. The results obtained from the annealed samples are consistent with those from the as-grown samples.

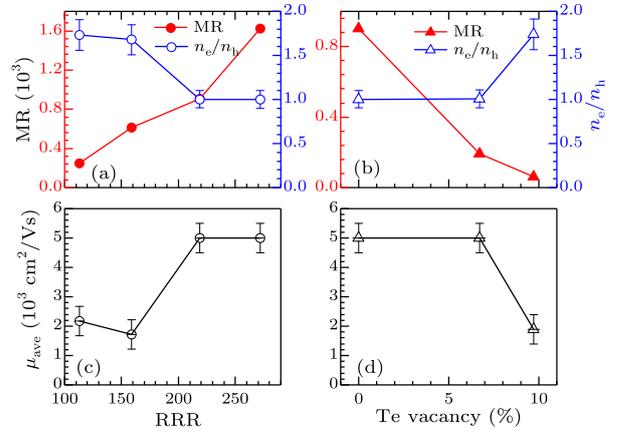


Fig. 3. (a) MR measured at 2 K and 9 T (filled circles), the fitting-resultant n_e/n_h (open circles), and (c) average mobility μ_{ave} (strike-through circles) as a function of RRR for the as-grown samples, obtained from Fig. 2. (b) MR (filled triangles), n_e/n_h (open triangles), and (d) μ_{ave} (strike-through triangles) as a function of Te vacancy for the annealed samples, obtained from Fig. 4.

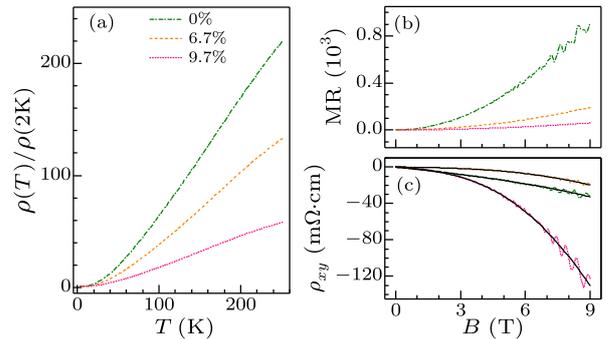


Fig. 4. (a) Temperature dependence of resistivity normalized by $\rho(2\text{K})$ for the annealed samples with different Te vacancies. (b) Longitudinal MR and (c) Hall resistivity taken at 2 K in a field range of 0–9 T. Non-oscillatory curves represent the fits to the two-band model.

Note that the information of carrier concentrations can also be extracted from the quantum oscillations revealed in the MR. After subtracting the non-oscillatory background from the MR data and employing fast Fourier transformation (FFT), four major fre-

quencies (i.e., 90 T, 123 T, 140 T, and 160 T) can be found in all of the samples, which are consistent with other research work on WTe_2 .^[24] However, no systematic difference that is beyond reasonable doubt can be detected among these samples, as shown in Figs. 5(a) and 5(b).

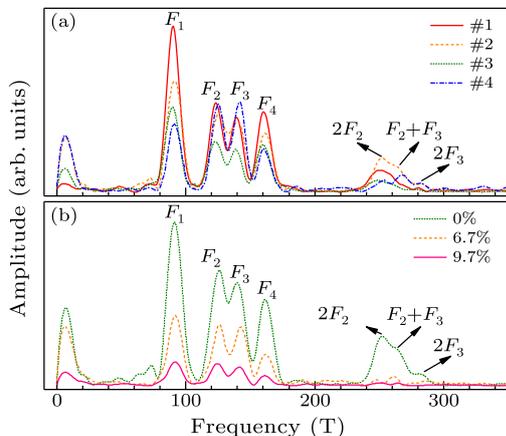


Fig. 5. FFT spectra of the quantum oscillations for (a) as-grown samples and (b) annealed samples.

For simplicity, a rough estimate can be given based on the free electron assumption, i.e., spherical Fermi surfaces for all the carrier pockets. The Fermi radii and carrier concentrations of four pockets are calculated and summarized in Table 1. We note that these values are generally consistent with those obtained from the two-band model fits. They have the same order of magnitude, i.e., 10^{19} cm^{-3} . Moreover, the total electron-type carrier concentration ($1.7 \times 10^{19} \text{ cm}^{-3}$) is roughly compensated for by the hole-type one ($1.62 \times 10^{19} \text{ cm}^{-3}$). The slightly larger electron-type carrier concentration agrees with the situation of electron doping, due to the Te deficiency. All these facts suggest that our measurements and analyses are convincing.

Table 1. Quantum oscillation frequencies, the calculated Fermi radii and carrier concentrations of four pockets in Fig. 5.

	F (T)	k_F (nm^{-1})	n (10^{19} cm^{-3})
F_1 (hole)	90	0.52	0.48
F_2 (electron)	123	0.61	0.77
F_3 (electron)	140	0.65	0.93
F_4 (hole)	160	0.70	1.14

Here we propose a possible scenario to explain the effect of carrier concentrations on the XMR in WTe_2 . From the band structure calculations and quantum oscillation analyses,^[23,24] the Fermi surfaces can be generally described by the two-band model, i.e., one electron-like band and one hole-like band. As illustrated in Fig. 6(a), the band structures around the Fermi level are composed of one electron-type pocket and one hole-type pocket. When the electron-type and hole-type carriers are completely compensated, which is also the stoichiometric case, the MR reaches its maximum value, according to the above equations. However, once the electron-type and hole-type carriers

become non-compensated, no matter what the reason is, the MR is reduced. In the present experiment, both the as-grown samples and the annealed samples have a certain degree of Te vacancies, i.e., electron doping. As seen in Fig. 6(b), the electron doping increases the Fermi level, which breaks the electron-hole balance and leads to a reduction in MR. A further reasonable guess is that the opposite situation, i.e., the hole doping with the hole-type carriers exceeding the electron-type carriers, may also comply with this rule. Moreover, our discussion is not involved with the possible topological transition in response to the change in Fermi level. Since the degree of non-stoichiometry in our samples is far away from the narrow window ($\sim 1\%$) for observing the chiral anomaly induced negative longitudinal MR,^[33] the decrease of XMR is unlikely related with the disappearance of the topological mechanism.

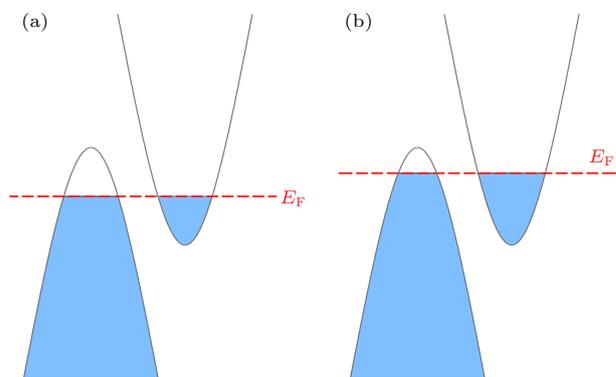


Fig. 6. Schematic illustration for the non-compensation effect in WTe_2 . Dashed lines indicate the Fermi level. Condition in (a) means perfect compensation of electron-type and hole-type carriers. (b) With electron doping, the electron-type carriers exceed the hole-type carriers. The less compensated ratio of n_e/n_h leads to a decrease in the XMR of WTe_2 .

In addition to the non-compensation of carrier densities, the non-stoichiometry effect may also lead to the change of carrier mobilities, because the existence of impurities and disorders would increase the scattering. The average carrier mobility (μ_{ave}) is found to strongly correlate with sample quality (i.e., RRR) and MR ratio.^[32] However, the analysis in that work is based on strongly simplified assumptions, i.e., $n_h = n_e = n$ and $\mu_h \approx \mu_e \approx \mu$, which are however impossible in actual cases. More seriously, these assumptions naturally lead to the relation of $\rho_{xx} \propto 1/\mu + \mu B^2$, and further MR ratio = $(\mu B)^2$ and RRR = $\rho_{300\text{K}}/\rho_{2\text{K}} \propto \mu_{2\text{K}}$. Researchers use this relation to fit the MR data and obtain the average mobility μ_{ave} , and deduce the linear correlation of μ_{ave} with RRR. Here we may find that the result has been already included in the initial assumption, which is inappropriate during data analysis. To solve this problem, we adopt the values of carrier mobilities that are obtained from the two-band model fits, and calculate the average mobility μ_{ave} with different weights (i.e., carrier densities n) of holes and electrons. As shown

in Fig. 3(c), with the increase of RRR, μ_{ave} indeed increases, consistent with Ref. [32]. However, we are not sure if the correlation is in a linear way, because of the limited data points. Such a correlation is confirmed on the annealed samples; namely, μ_{ave} is suppressed by the increase of Te vacancies (Fig. 3(d)).

These results suggest that the existence of impurities or disorders causes not only the non-compensation of carrier densities but also the reduction of average carrier mobility, both of which play an important role in the XMR. The largest MR arises from the combined effect of the most compensated carriers and the highest average mobility.

Before ending the present work, we may talk more about the relationship between XMR and topological semimetal states. Although all the found topological semimetals seem to exhibit the XMR effect, the observation of XMR does not necessarily prove the existence of topological semimetal states. For some XMR materials like LaSb,^[16] distinct trivial features are revealed by first-principles calculations and ARPES experiment.^[21,34] In such a system, the XMR may just originate from the compensation effect and/or ultrahigh carrier mobilities, and not be relevant to any topological mechanism.

In conclusion, the non-stoichiometry effect on the XMR has been investigated for the Weyl semimetal WTe₂. MR and Hall resistivity are measured for the as-grown samples with a slight difference in Te vacancies and the annealed samples with increased Te vacancies. The fits to a two-band model show that the MR is strongly dependent on the RRR (i.e., the degree of non-stoichiometry), which is eventually understood in terms of electron doping, which not only breaks the balance between n_e and n_h but also reduces the

average mobility μ_{ave} . Thus the compensation effect and ultrahigh mobility are probably the main driving forces of the XMR in WTe₂.

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